

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/724,717	SU, WEN-WEI	
Examiner		Art Unit		Page 1 of 1
John A. Tweel, Jr.		2636		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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